

# STP80NF12

## N-channel 120V - 0.013Ω - 80A - TO-220 STripFET™ II Power MOSFET

### **General features**

Туре	V <sub>DSS</sub> (@Tjmax)	R <sub>DS(on)</sub>	I <sub>D</sub>
STP80NF12	120V	<0.018Ω	80A <sup>(1)</sup>

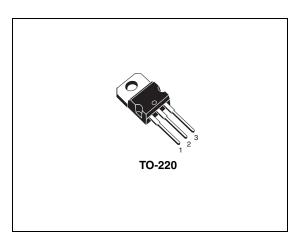
- Exceptional dv/dt capability
- 100% avalanche tested
- Application oriented characterization

### Description

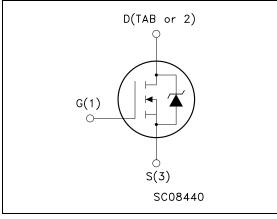
This MOSFET series realized with STMicroelectronics unique STripFET process has specifically been designed to minimize input capacitance and gate charge. It is therefore suitable as primary switch in advanced highefficiency, high-frequency isolated DC-DC converters for Telecom and Computer applications. It is also intended for any applications with low gate drive requirements.

## Applications

Switching application



### Internal schematic diagram



### **Order codes**

Part number	Marking	Package	Packaging
STP80NF12	P80NF12	TO-220	Tube

January	2007
January	2007

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## 1 Electrical ratings

Absolute maximum ratings			
Devenuelar	Valu	e	11
Parameter	STB_P_W80NF12	STP80NF12FP	Unit
Drain-source voltage ( $V_{GS} = 0$ )	120		V
Drain-gate voltage ( $R_{GS} = 20K\Omega$ )	120		V
Gate-source voltage	± 22	2	V
Drain current (continuous) at $T_C = 25^{\circ}C$	80	11 <sup>(2)</sup>	А
Drain current (continuous) at T <sub>C</sub> =100°C	60	60 <sup>(2)</sup>	А
Drain current (pulsed)	320	320 <sup>(2)</sup>	А
Total dissipation at $T_{C} = 25^{\circ}C$	300	45	W
Derating factor	2.0	0.3	W/°C
Peak diode recovery voltage slope	10		V/ns
Insulation withstand voltage (DC)		2500	V
Operating junction temperature Storage temperature	-55 to	175	°C
	ParameterDrain-source voltage ( $V_{GS} = 0$ )Drain-gate voltage ( $R_{GS} = 20K\Omega$ )Gate-source voltageDrain current (continuous) at $T_C = 25^{\circ}C$ Drain current (continuous) at $T_C=100^{\circ}C$ Drain current (pulsed)Total dissipation at $T_C = 25^{\circ}C$ Derating factorPeak diode recovery voltage slopeInsulation withstand voltage (DC)Operating junction temperature	ValuParameterValuSTB_P_W80NF12Drain-source voltage ( $V_{GS} = 0$ )120Drain-gate voltage ( $R_{GS} = 20K\Omega$ )120Gate-source voltage $\pm 22$ Drain current (continuous) at $T_C = 25^{\circ}C$ 80Drain current (continuous) at $T_C = 100^{\circ}C$ 60Drain current (pulsed)320Total dissipation at $T_C = 25^{\circ}C$ 300Derating factor2.0Peak diode recovery voltage slope10Insulation withstand voltage (DC)Operating junction temperature-55 to	ValueParameterSTB_P_W80NF12STP80NF12FPDrain-source voltage ( $V_{GS} = 0$ )120Drain-gate voltage ( $R_{GS} = 20K\Omega$ )120Gate-source voltage $\pm 22$ Drain current (continuous) at $T_C = 25^{\circ}C$ 8011 (2)Drain current (continuous) at $T_C = 100^{\circ}C$ 6060 (2)Drain current (pulsed)320320 (2)Total dissipation at $T_C = 25^{\circ}C$ 30045Derating factor2.00.3Peak diode recovery voltage slope10Insulation withstand voltage (DC)2500Operating junction temperature-55 to 175

#### Table 1. Absolute maximum ratings

1. Limited by Package

2. Limited only by maximum temperature allowed

3. Pulse width limited by safe operating area

4. Starting  $T_J = 25 \ ^{o}C$ ,  $I_D = 40A$ ,  $V_{DD} = 45V$ 

			Value		
Symbol	Parameter	TO-247	D <sup>2</sup> PAK TO-220	TO-220FP	Unit
R <sub>thJC</sub>	Thermal resistance junction-case Max	0.5	0.5	3.33	°C/W
R <sub>thJA</sub>	Thermal resistance junction-ambient Max	50	62.5	62.5	°C/W
Τ <sub>Ι</sub>	Maximum lead temperature for soldering purpose	300	300	300	°C

## 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 250μΑ, V <sub>GS</sub> = 0	120			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = Max rating, V <sub>DS</sub> = Max rating @125°C			1 10	μA μA
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	$V_{GS} = \pm 20V$			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2			V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 40A		0.013	0.018	Ω

#### Table 3. On/off states

#### Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	V <sub>DS</sub> =15V, I <sub>D</sub> = 40A		80		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> =25V, f=1 MHz, V <sub>GS</sub> =0		4300 600 230		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	V <sub>DD</sub> = 80V, I <sub>D</sub> = 80A V <sub>GS</sub> =10V		140 23 51	189	nC nC nC

1. Pulsed: pulse duration=300 $\mu$ s, duty cycle 1.5%

#### Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD}$ = 50 V, $I_D$ = 40A, R <sub>G</sub> =4.7 $\Omega$ , V <sub>GS</sub> =10V Figure 13 on page 8		40 145 134 115		ns ns ns ns

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current				80	A
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)				320	A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> =80A, V <sub>GS</sub> =0			1.3	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>SD</sub> =80A, di/dt = 100A/μs, V <sub>DD</sub> =35V, Τ <sub>J</sub> = 150°C		155 0.85 11		ns μC Α

 Table 6.
 Source drain diode

1. Pulse width limited by safe operating area

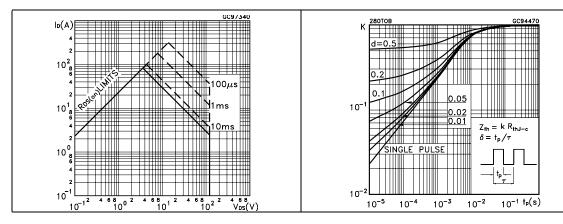
2. Pulsed: pulse duration=300µs, duty cycle 1.5%



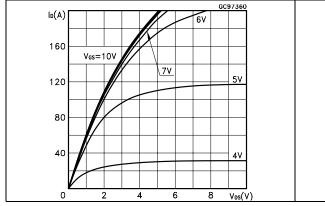
### 2.1 Electrical characteristics (curves)

#### Figure 1. Safe operating area

Figure 2. Thermal impedance











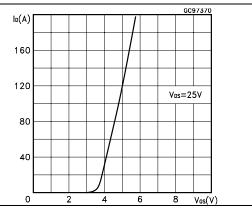
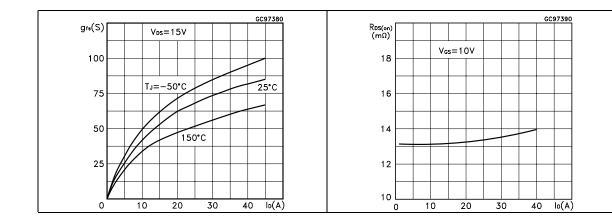
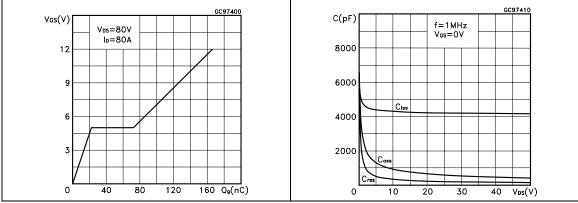


Figure 6. Static drain-source on resistance





#### Gate charge vs. gate-source voltage Figure 8. Capacitance variations Figure 7.

Figure 9. Normalized gate threshold voltage vs. temperature

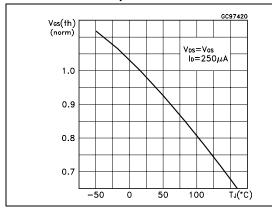


Figure 11. Source-drain diode forward characteristics

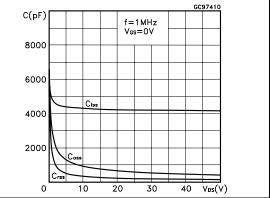


Figure 10. Normalized on resistance vs. temperature

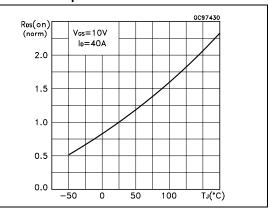
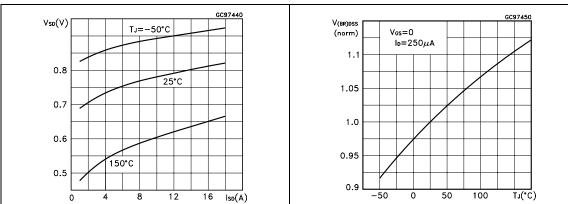


Figure 12. Normalized  $\mathsf{B}_{\mathsf{VDSS}}$  vs. temperature



## 3 Test circuit

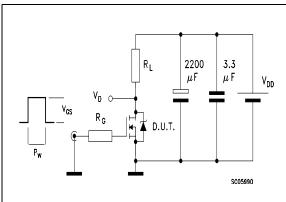


Figure 15. Test circuit for inductive load switching and diode recovery times

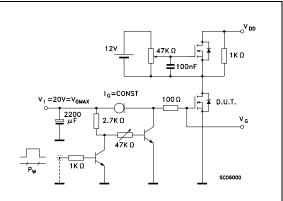


Figure 16. Unclamped Inductive load test

L

JUI

D.U.T.

2200 μF

3.3

μF

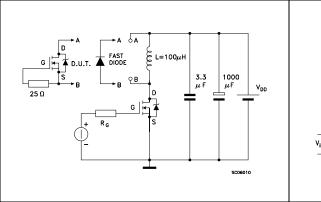
SC05970

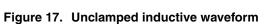
 $V_{\rm DD}$ 

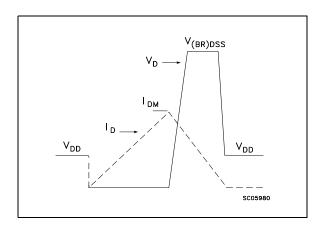
V<sub>D</sub>  $_{\odot}$ 

۱<sub>D</sub>













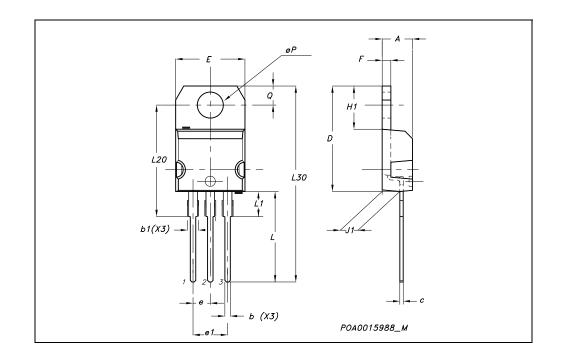
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



DIM.		mm.			inch	
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
С	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
Е	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øP	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116





## 5 Revision history

### Table 7. Revision history

Date	Revision	Changes
21-Jun-2004	2	Preliminary version
24-Jul-2006	3	The document has been reformatted, SOA updated
31-Jan-2007	4	Typo mistake on Table 1.



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